

*Review of Progress in Quantitative NDE  
Bowdoin College, Brunswick, ME*

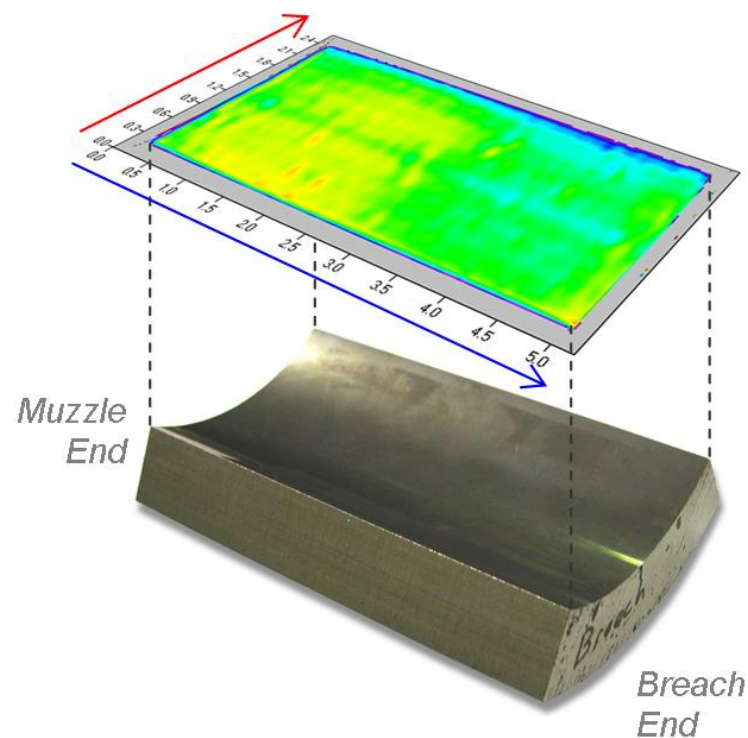
*July 31-August 5, 2005*

# Quality Assessment of Refractory Protective Coatings using Multi- Frequency Eddy Current MWM-Arrays

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# Erosion and Thermal Shock Resistive Coatings

- Increased **range**, **rate of fire**, and **muzzle velocity** have resulted in **increased wear and erosion problems** in gun tubes coated with electroplated chromium
- Dry physical vapor deposition (**PVD**) processes such as cylindrical magnetron sputtering (**CMS**) are being developed to **increase the service life** of gun tubes and address the **environmental considerations** associated with electroplating chromium
- Quantitative **NDE** of coatings deposited by CMS is crucial to the continued development and statistical process control of these emerging **manufacturing processes**

## **NEED:**

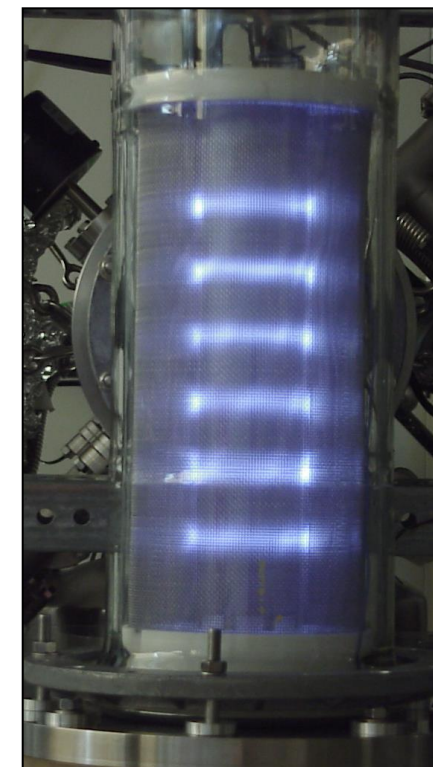
- Coating **thickness** measurement
- Verification of **coating phase composition**

# Objectives

1. Provide nondestructive characterization of the following properties of CMS deposited tantalum coatings on gun barrel steel:
  - Tantalum coating thickness
  - Phase composition, i.e.,  $\alpha$ -, ( $\alpha+\beta$ )- or  $\beta$ -phase Ta  
( $\alpha$  – good)
  - Imaging/identification of lower conductivity areas  
(indicating presence of  $\beta$ -phase tantalum)
2. Develop scanner for gun barrels

# Cylindrical Magnetron Sputtering

(Low temperature deposition)



“Plasma rings”

Full length gun barrel sputtering chamber

# Perspective

## *Large Caliber Gun Firing Environment*

- Internal Pressure can exceed 100 ksi (690 MPa)
- Peak gun bore T can exceed 1400C
- Highly transient nature of gun firing results in extreme thermal shock environment (e.g. 200x more aggressive than in the gas turbine industry).

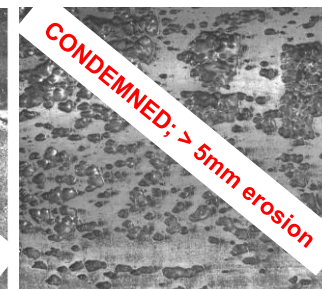
Adhesion is paramount.

- Aggressive propellant by-products such as CO & H<sub>2</sub>S
- Coatings must be deposited at T < ~350C



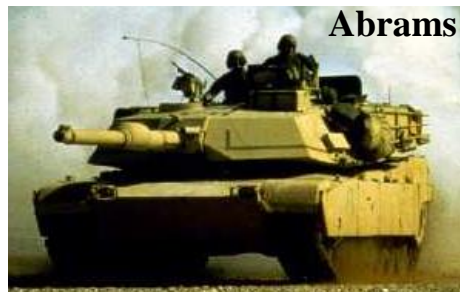
**ABRAMS 120mm Gun Barrel**

101 M829 rounds  
771 Total rounds



**ABRAMS 120mm Gun Barrel**

39 Candidate high energy rounds  
214 Total rounds



**Abrams**



**FCS MCS**

(Developmental)



**FCS NLOS-C**

(Developmental)



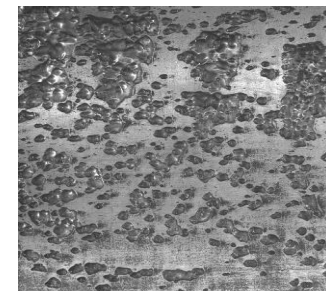
**Navy AGS**

(Developmental)

# Why Cylindrical Magnetron Sputtering?



- Extend the life/performance of gun barrels, *reduce logistics burden, enhance lethality, cost avoidance*
- Most mature, next generation coating process for Lg Cal gun barrels
- Scaleable and flexible technology
- Preserves the beneficial residual compressive stresses in Lg Cal gun barrels
- Replace the current process, Cr electroplating, a hazardous process



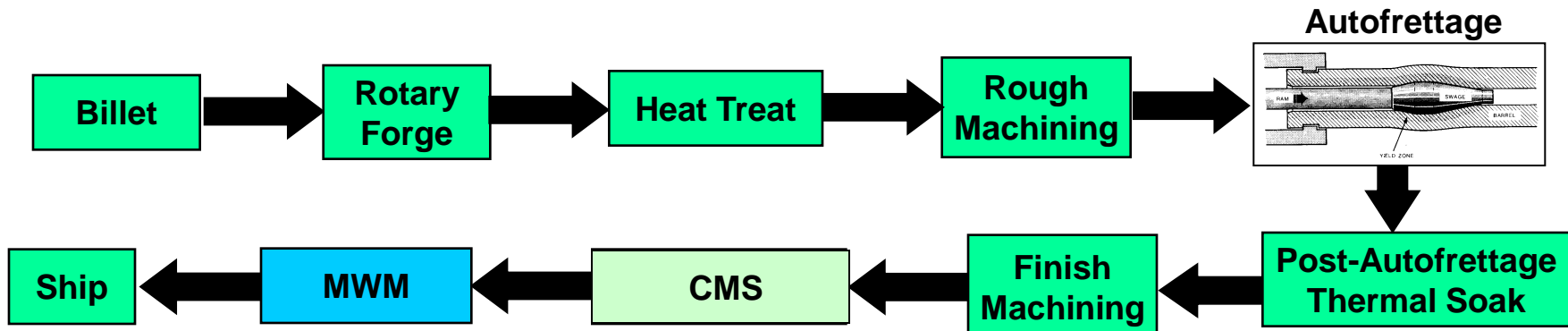
Erosion in Gun Barrel



Toxic sludge from Cr plating

# LG Cal Gun Barrel Manufacturing Sequence

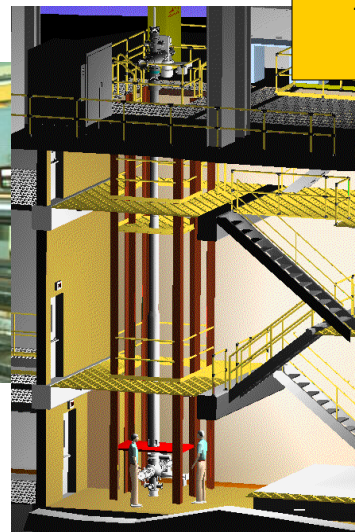
*CMS will not alter barrel manufacturing sequence*



Rotary Forging



Machining



CMS

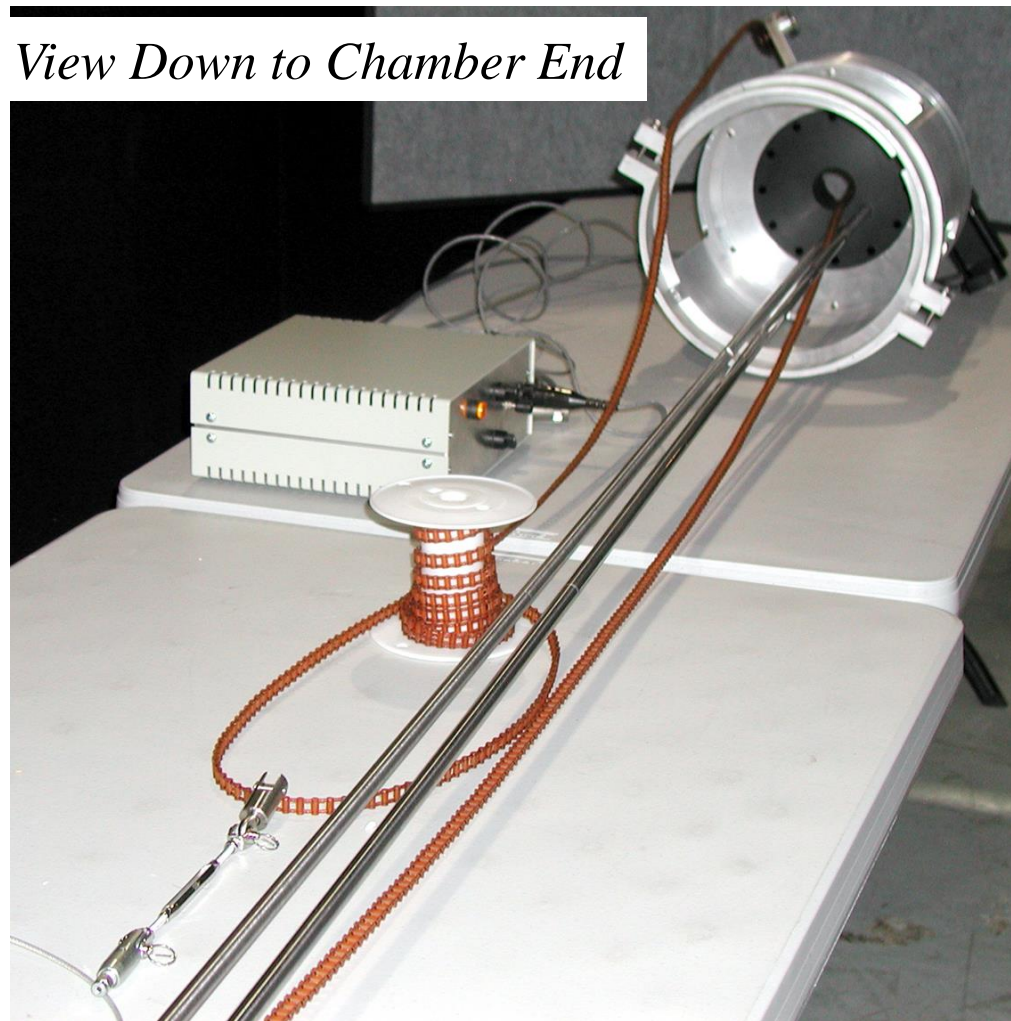
CMS technology can be "plugged in" to the current barrel manufacturing process w/o alteration



Fielding

# Gun Barrel Inspection Fixture

*View Down to Chamber End*

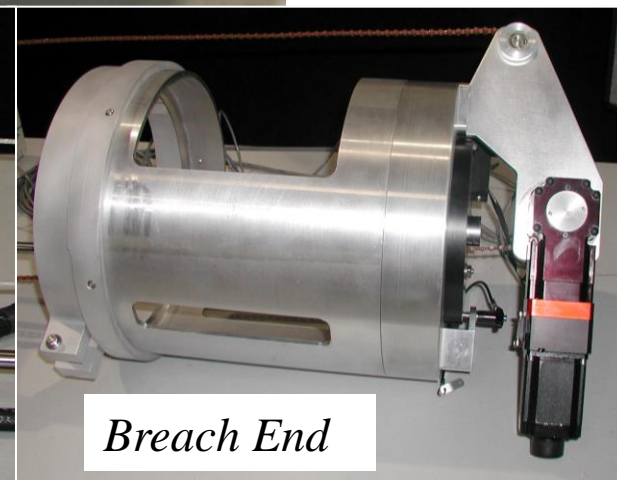
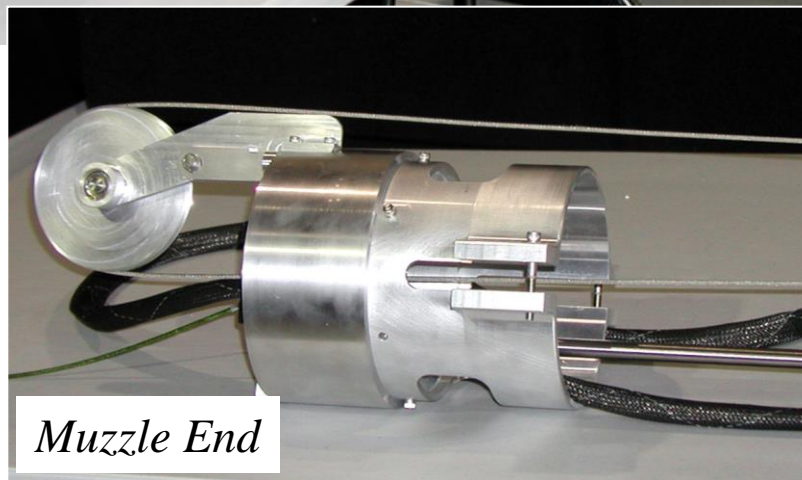
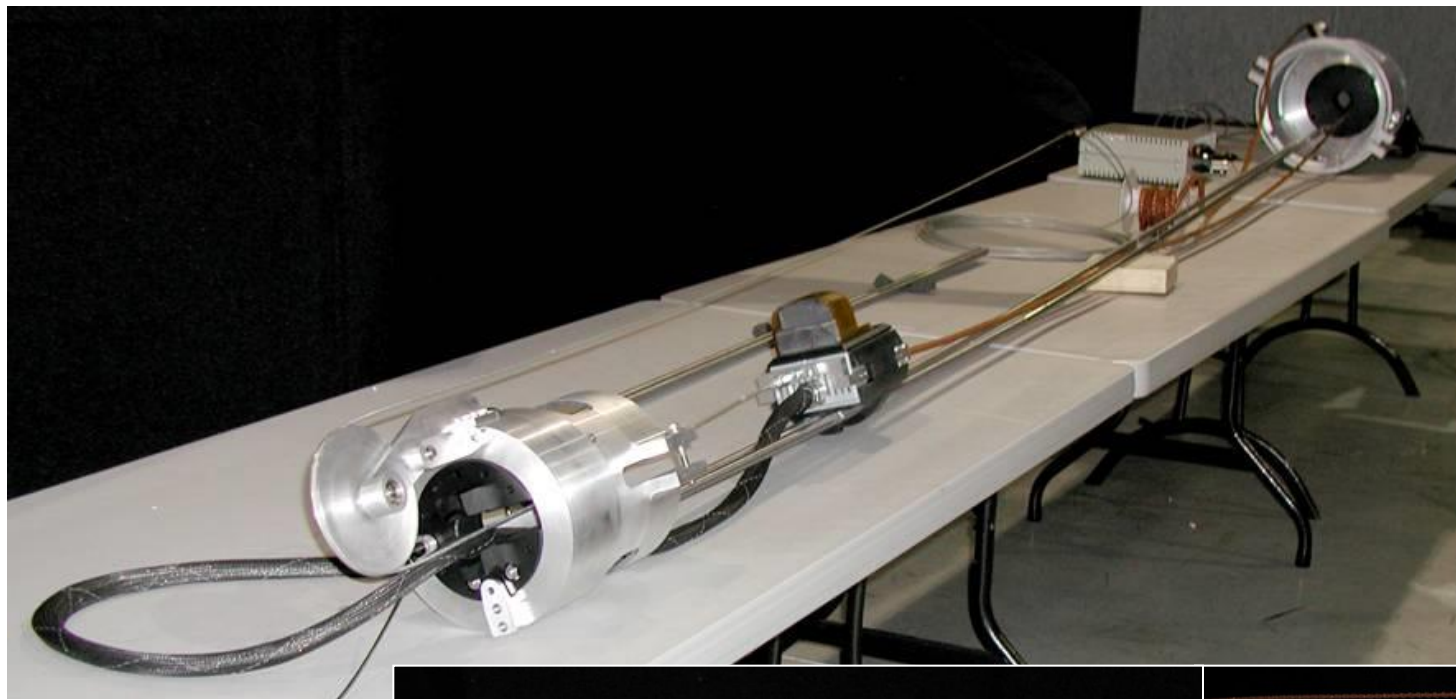


*Adapted MWM-Array Probe (Angle Shot)*





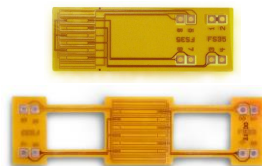
# Gun Barrel Inspection Fixture



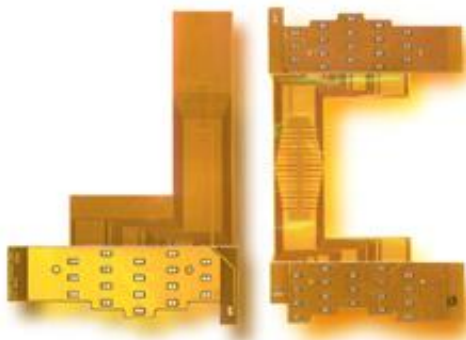
# Measurement Method

- Multifrequency electrical conductivity measurements
- Meandering Winding Magnetometer (MWM)
- Scanning MWM-Arrays
- Multivariate inversion methods for multiple property measurements

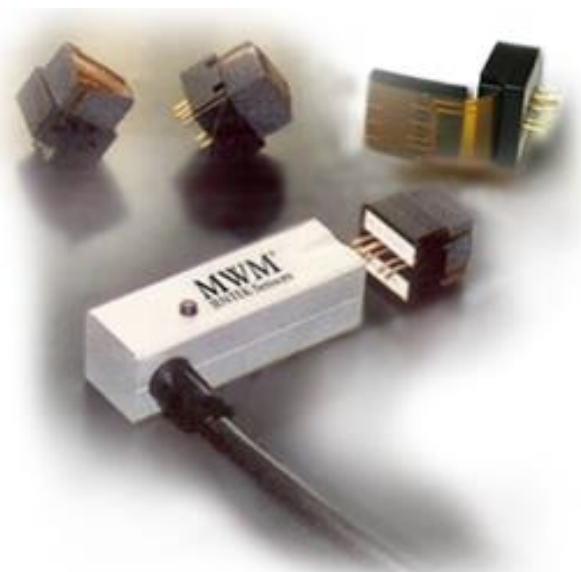
Single channel MWM



Multi-channel  
MWM-Arrays

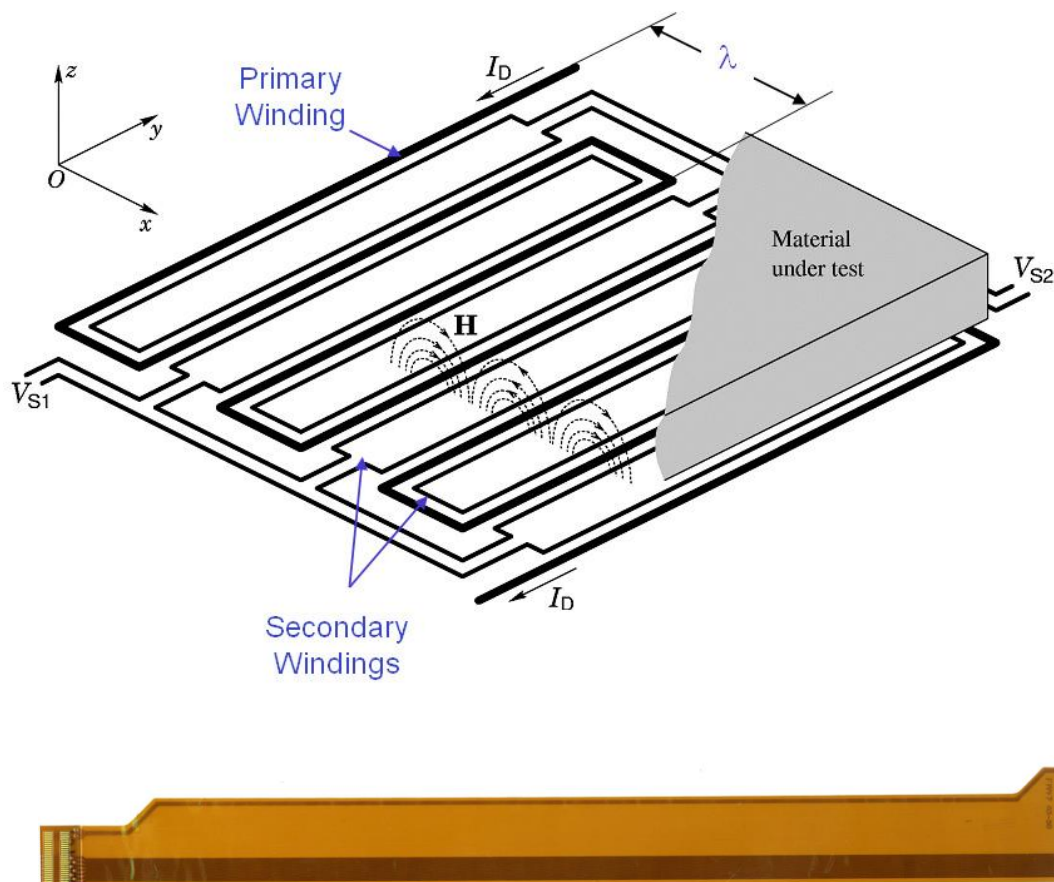


JENTEK GridStation Setup with  
39-Channel Instrument and  
39-Channel **MWM-Array** Probe



Single Channel **MWM**  
Probe with  
Interchangeable Tips

# Meandering Winding Magnetometer (MWM®)



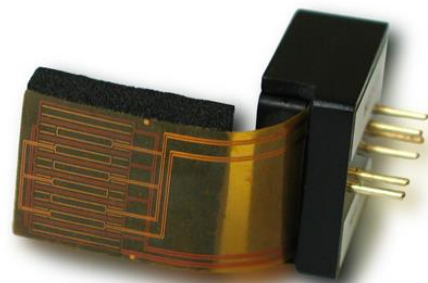
- Thin, flexible
- Conformable to complex geometries
- Designed to fit the physics-based model

Transfer Impedance = Secondary Voltage / Primary (input) Current

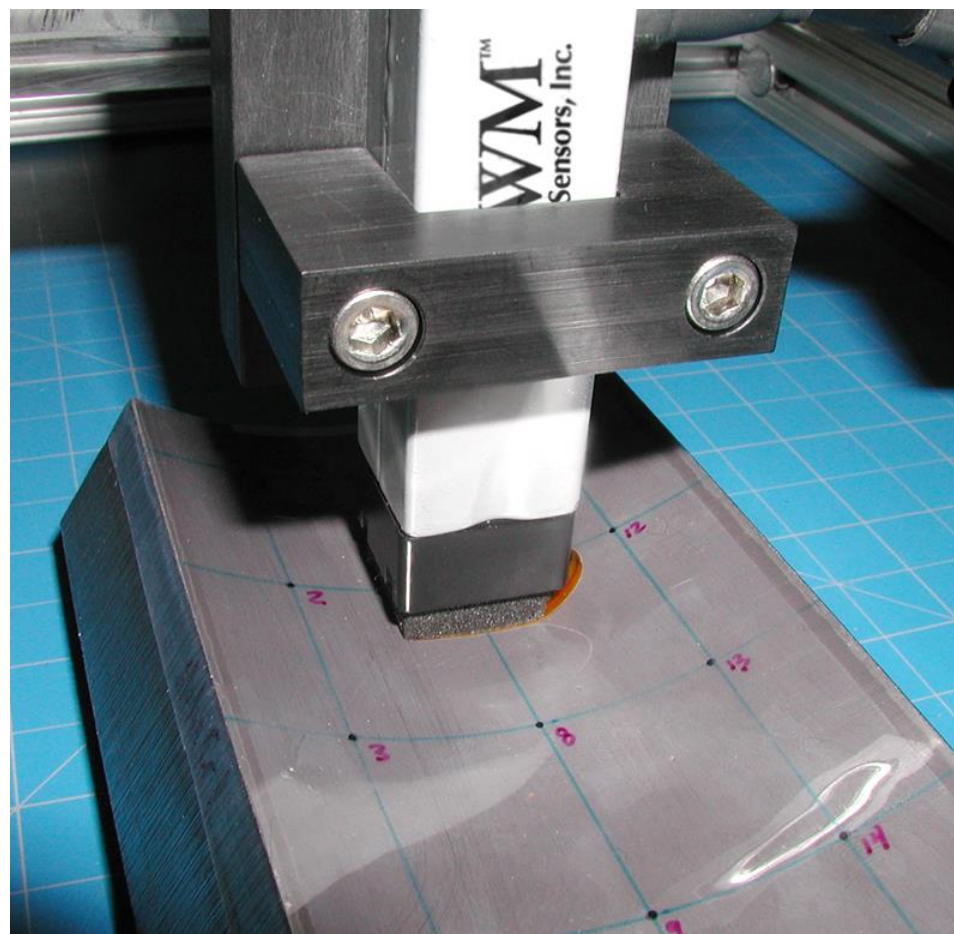
# Single Channel Sensor MWM



FS35 MWM sensor

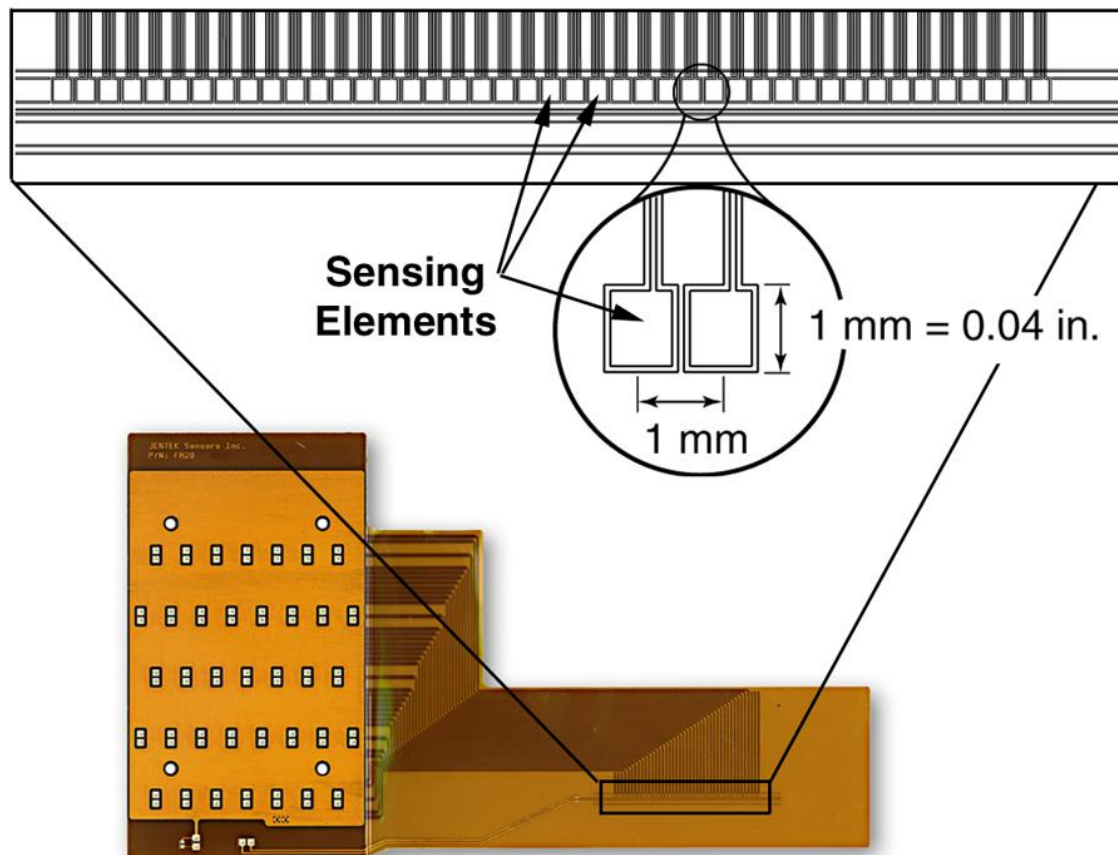


FS35 MWM sensor tip



FS35 probe fixture in use

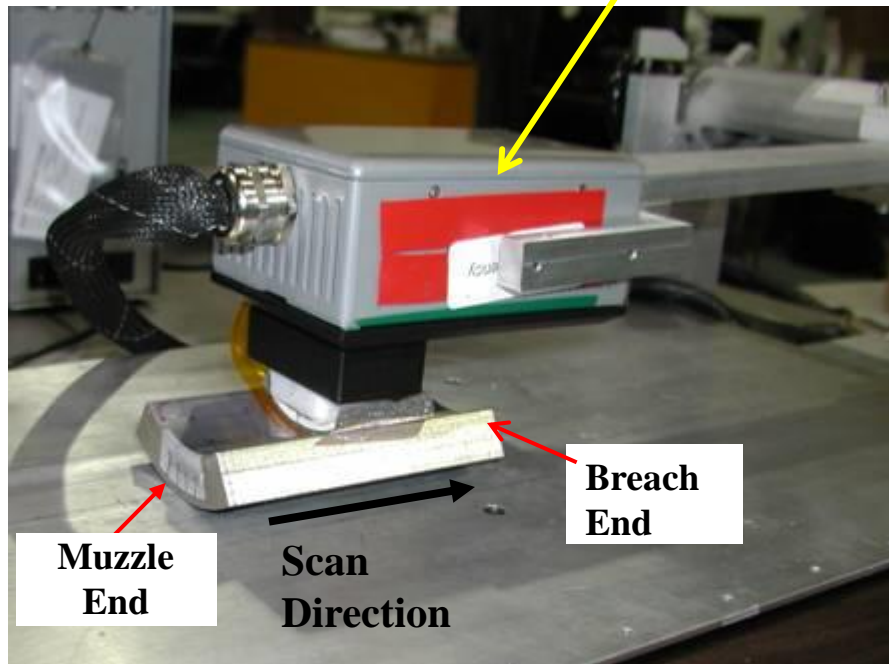
# MWM-Array Sensor with 37 Channels (FA28)



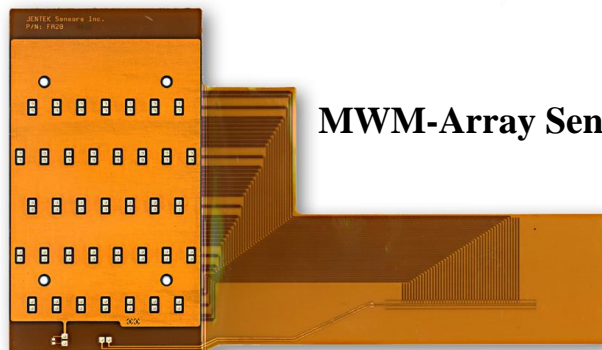
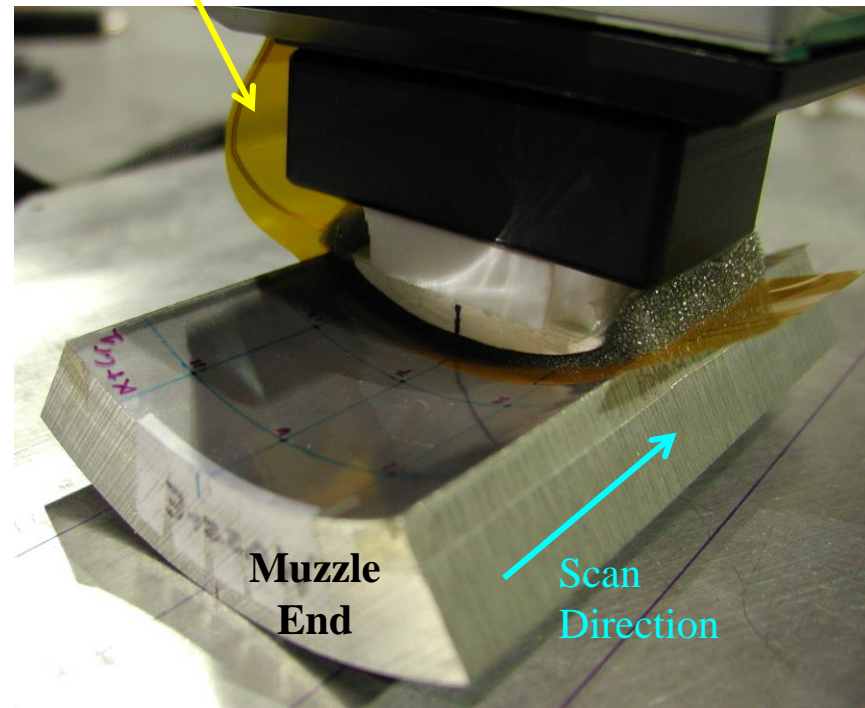
- Scan width = 37 sensing elements = 37 mm (1.48 in.)

# Scanning with Multi-Channel MWM-Arrays

MWM-Array probe

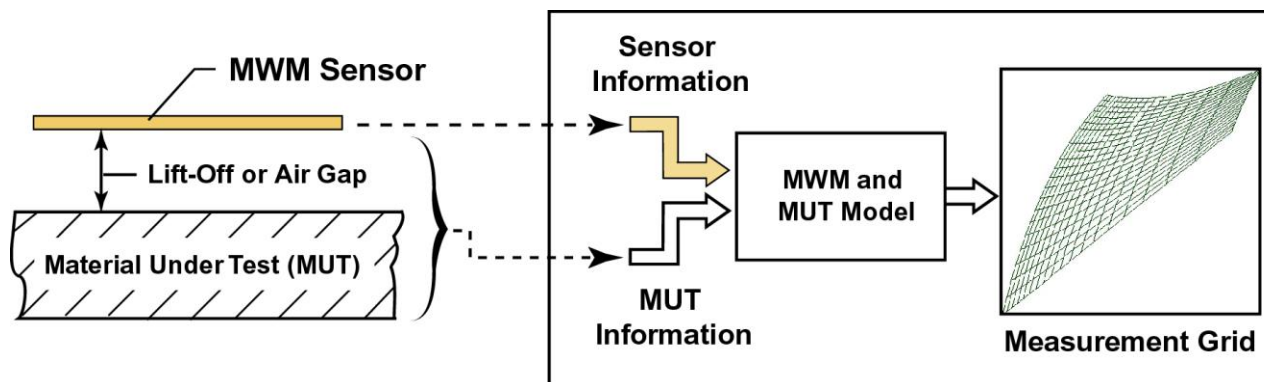


MWM-Array Sensor

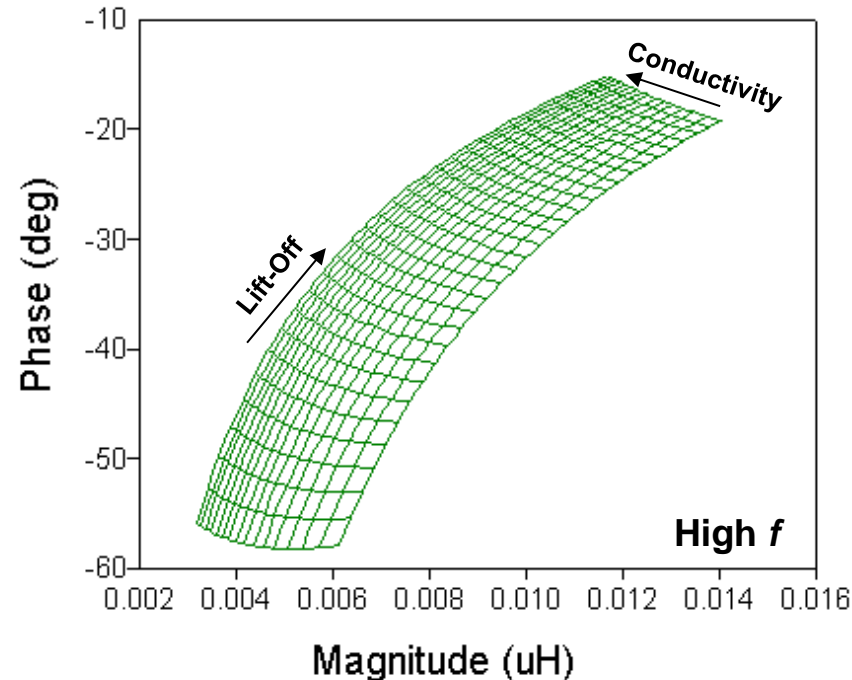
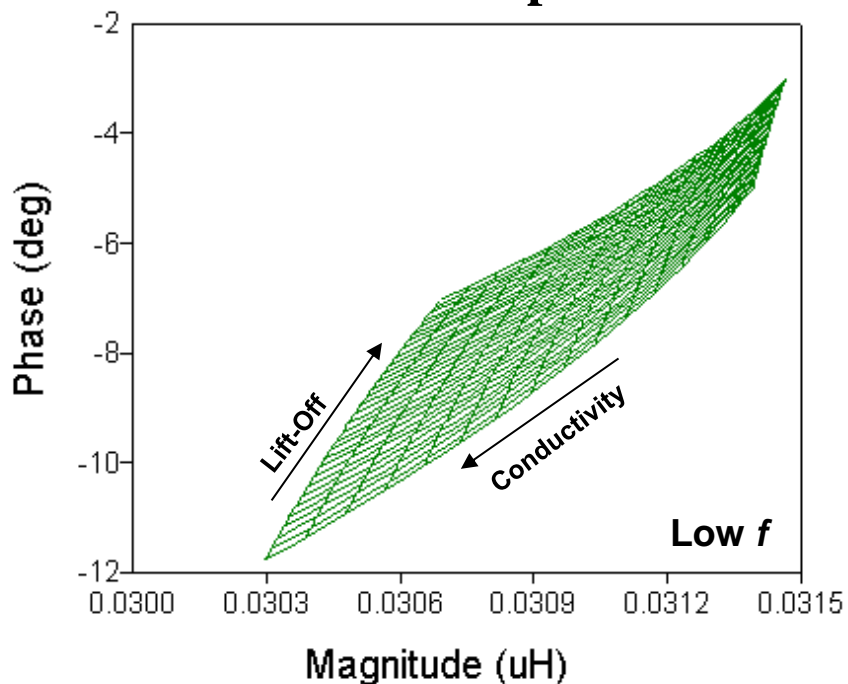


MWM-Array Sensor FA28

# Conductivity / Lift-off Measurement Grids



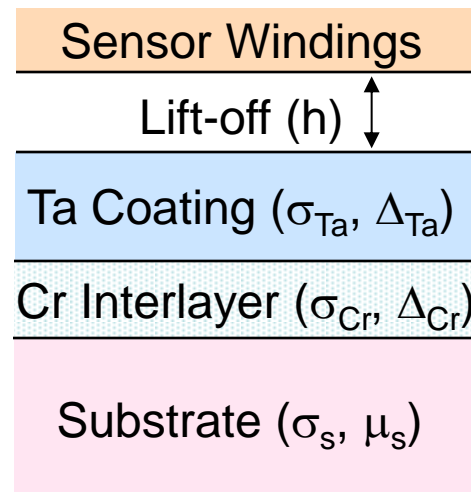
## Example Grids for the MWM-FS35 Sensor



# Measurement Grid Hyper-Cubes

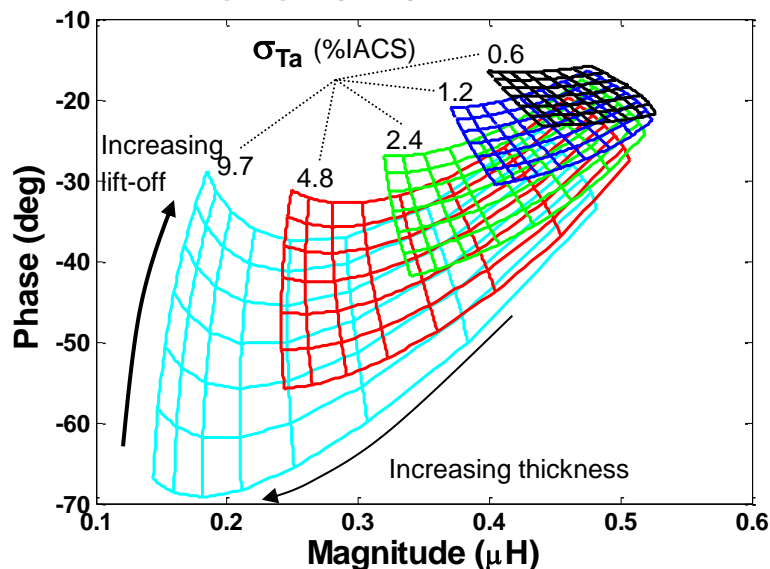
(patents issued and pending)

- A 3-D Lattice is a collection of 2-D grids
  - Tantalum conductivity, tantalum thickness, and lift-off (assuming values for substrate permeability and conductivity, and chromium interlayer thickness and conductivity)
- Approach:
  - Use lattices to find properties that are independent of frequency



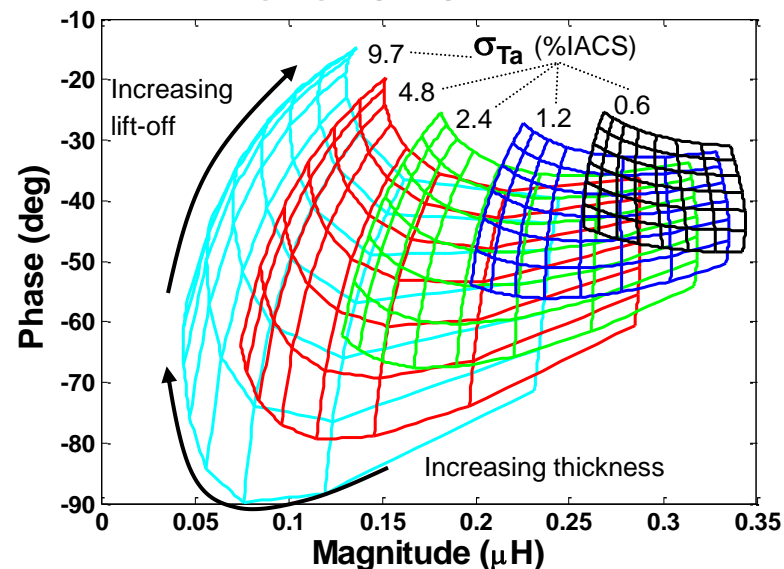
## Low $f$ $\sigma_{Ta}$ - $\Delta_{Ta}$ - $h$ Lattice

$\mu_s$ ,  $\sigma_s$ ,  $\sigma_{Cr}$ ,  $\Delta_{Cr}$  constant



## High $f$ $\sigma_{Ta}$ - $\Delta_{Ta}$ - $h$ Lattice

$\mu_s$ ,  $\sigma_s$ ,  $\sigma_{Cr}$ ,  $\Delta_{Cr}$  constant





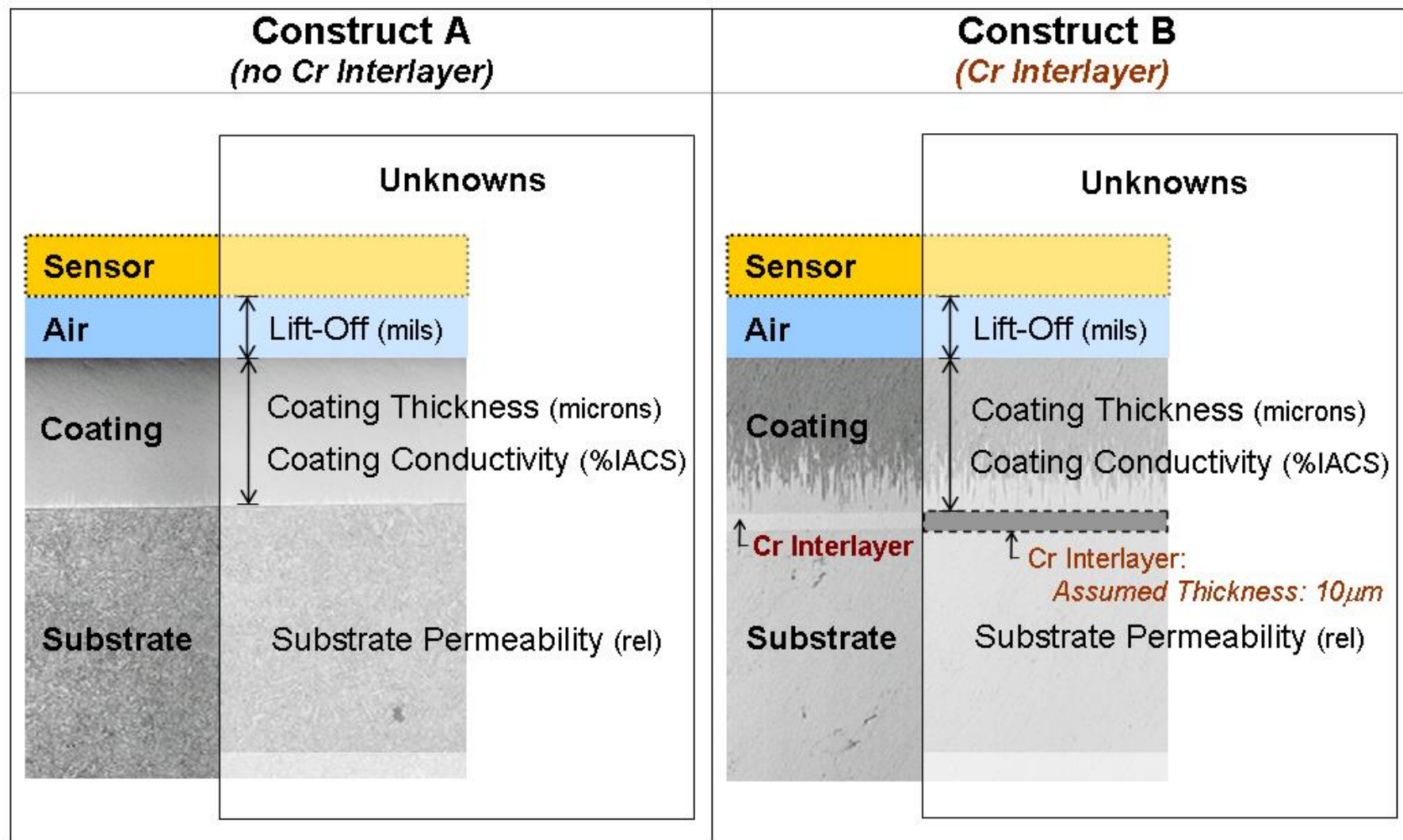
# Analysis Model:

JENTEK's patented **4-unknown inversion method** was used to characterize the properties of the tantalum coating and steel substrate. The four unknowns measured in this approach are:

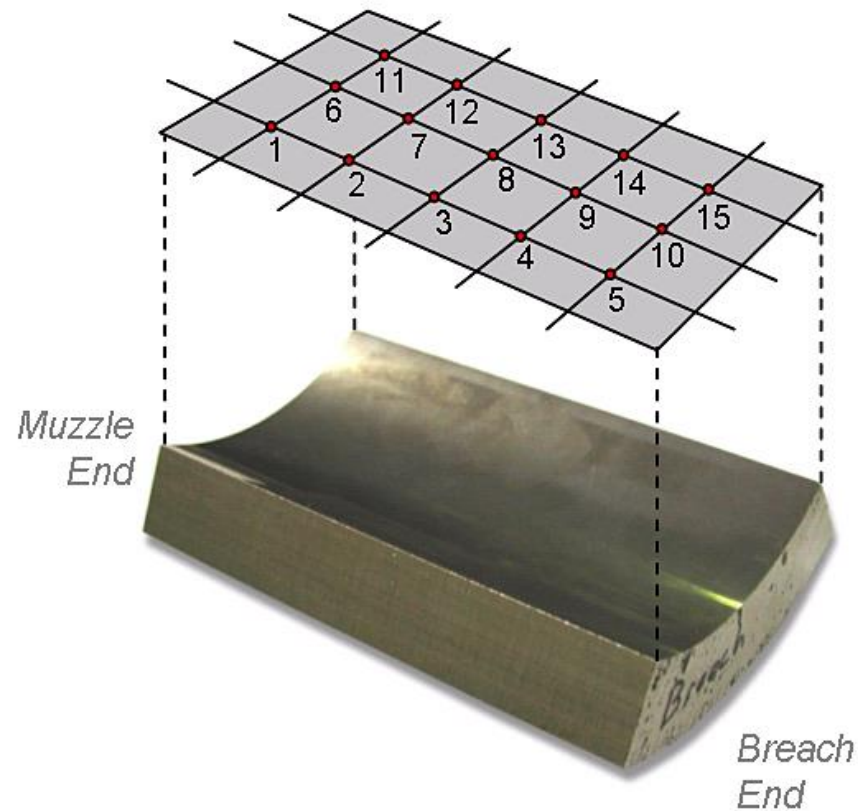
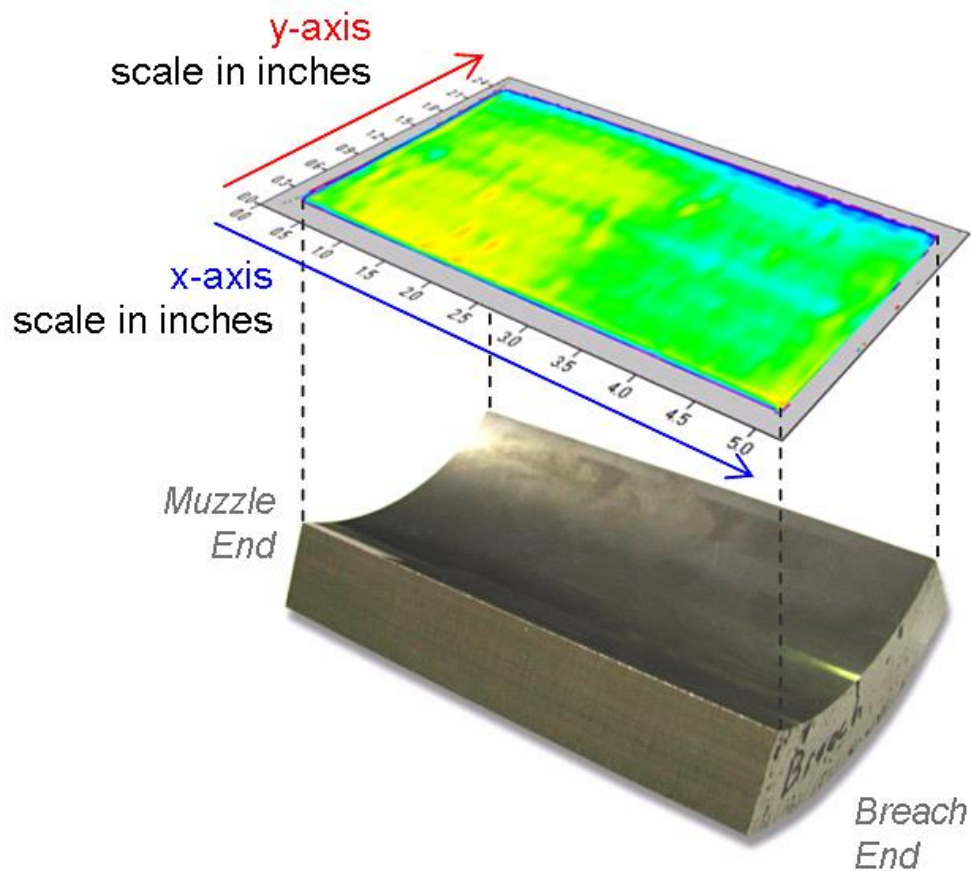
- 1) Lift-off
- 2) Tantalum Coating Conductivity
- 3) Tantalum Coating Thickness
- 4) Steel Substrate Permeability

Substrate conductivity and chromium interlayer thickness and conductivity are assumed.

# Schematics of 4-Unknown Constructs



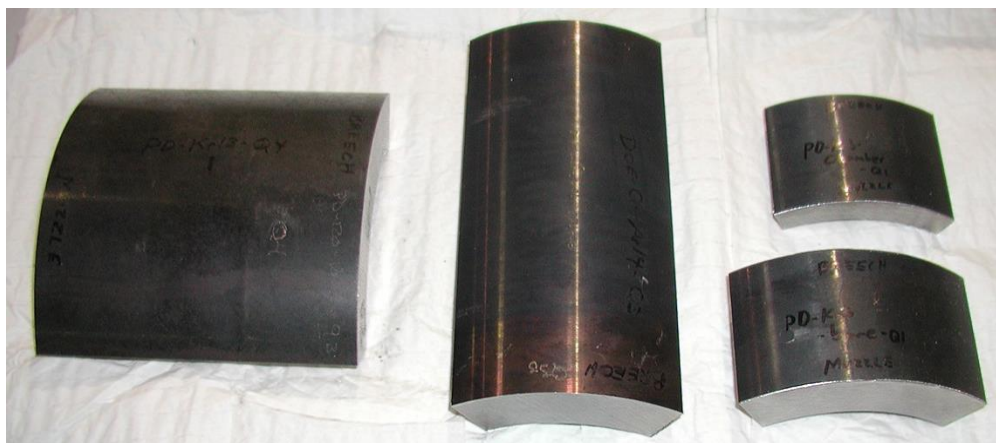
# Example of MWM-Array Conductivity Image and Corresponding Sample



# Matrix of the Samples Analyzed by JENTEK

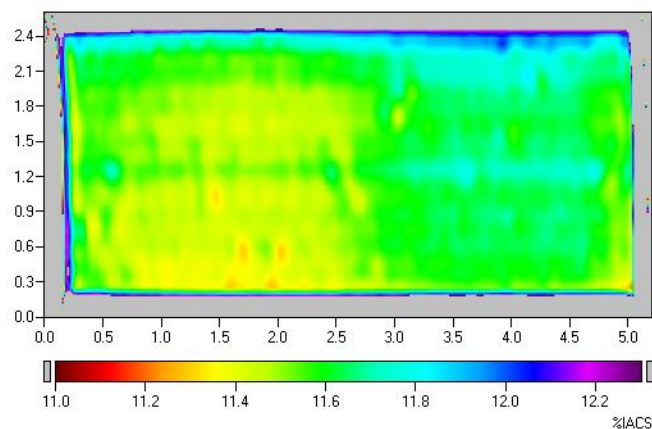
			Sputtering Gas	
			Ar	Kr
<b>Coating Composition</b>	<b>Majority <math>\alpha</math>-Tantalum</b>	100% Alpha	X	
		100% Alpha <i>with Cr</i>		X
		Mixed Phase (majority alpha)	X	
		Mixed Phase (majority alpha) <i>with Cr</i>		X
	<b>Majority <math>\beta</math>-Tantalum</b>	Mixed Phase (majority beta)		
		Mixed Phase (majority beta) <i>with Cr</i>		
		100% Beta	X	
		100% Beta <i>with Cr</i>		

## Samples

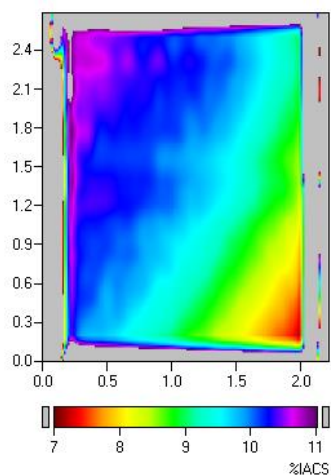


# Examples of Coating Conductivity Images (Samples Sputtered in Krypton)

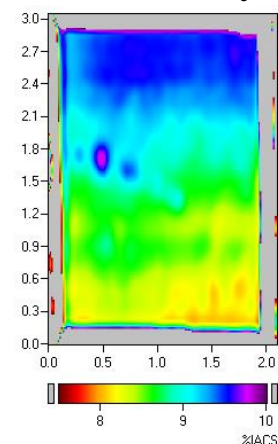
**Sample 4:**  $\alpha$ -Phase Tantalum with Cr Interlayer



**Sample 6:** ( $\alpha + \beta$ ) Tantalum with Cr Interlayer

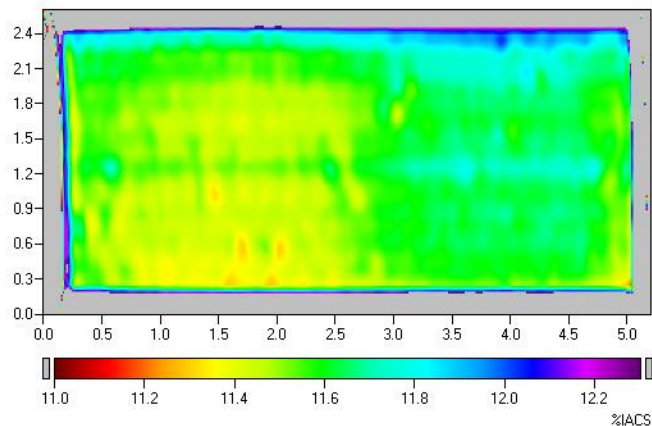


**Sample 7:** ( $\alpha + \beta$ ) Tantalum with Cr Interlayer

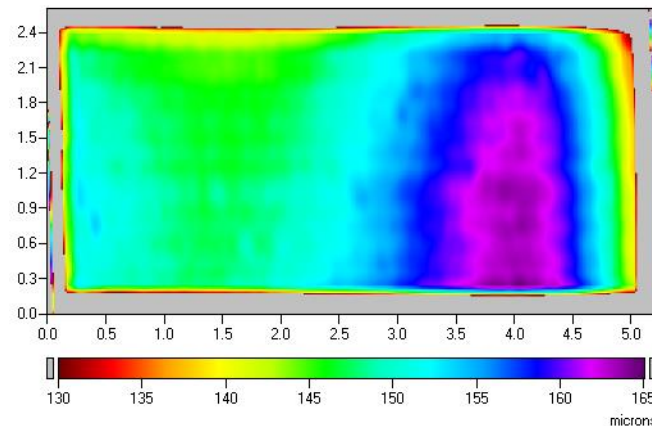


# MWM-Array Images of Tantalum Coated Gun Barrel Steel

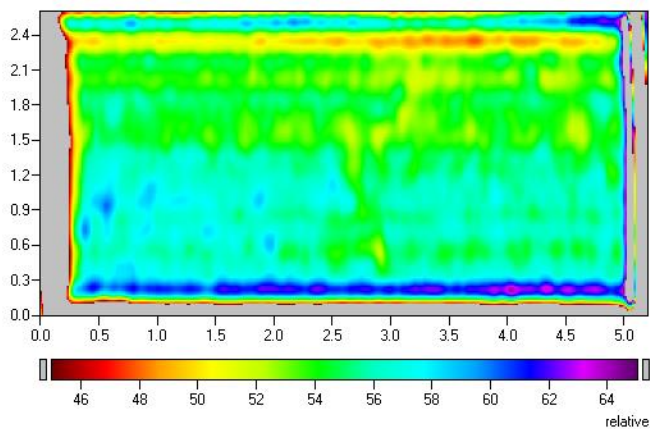
FA28 Scans of Sample PD-120-Kr10-Q1, 99% Alpha-Ta with Sputtered Cr Interlayer



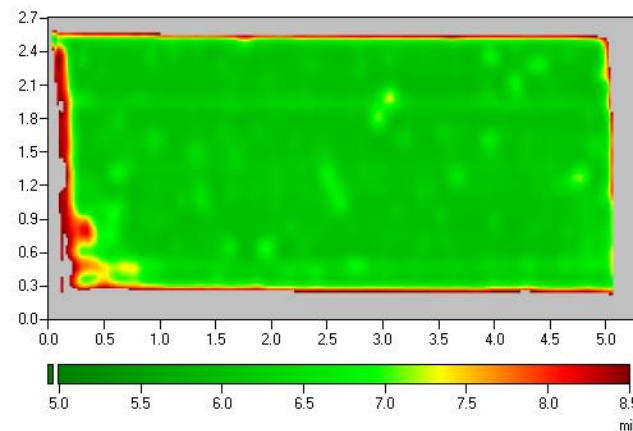
Tantalum Coating Conductivity (%IACS)



Tantalum Coating Thickness (*microns*)

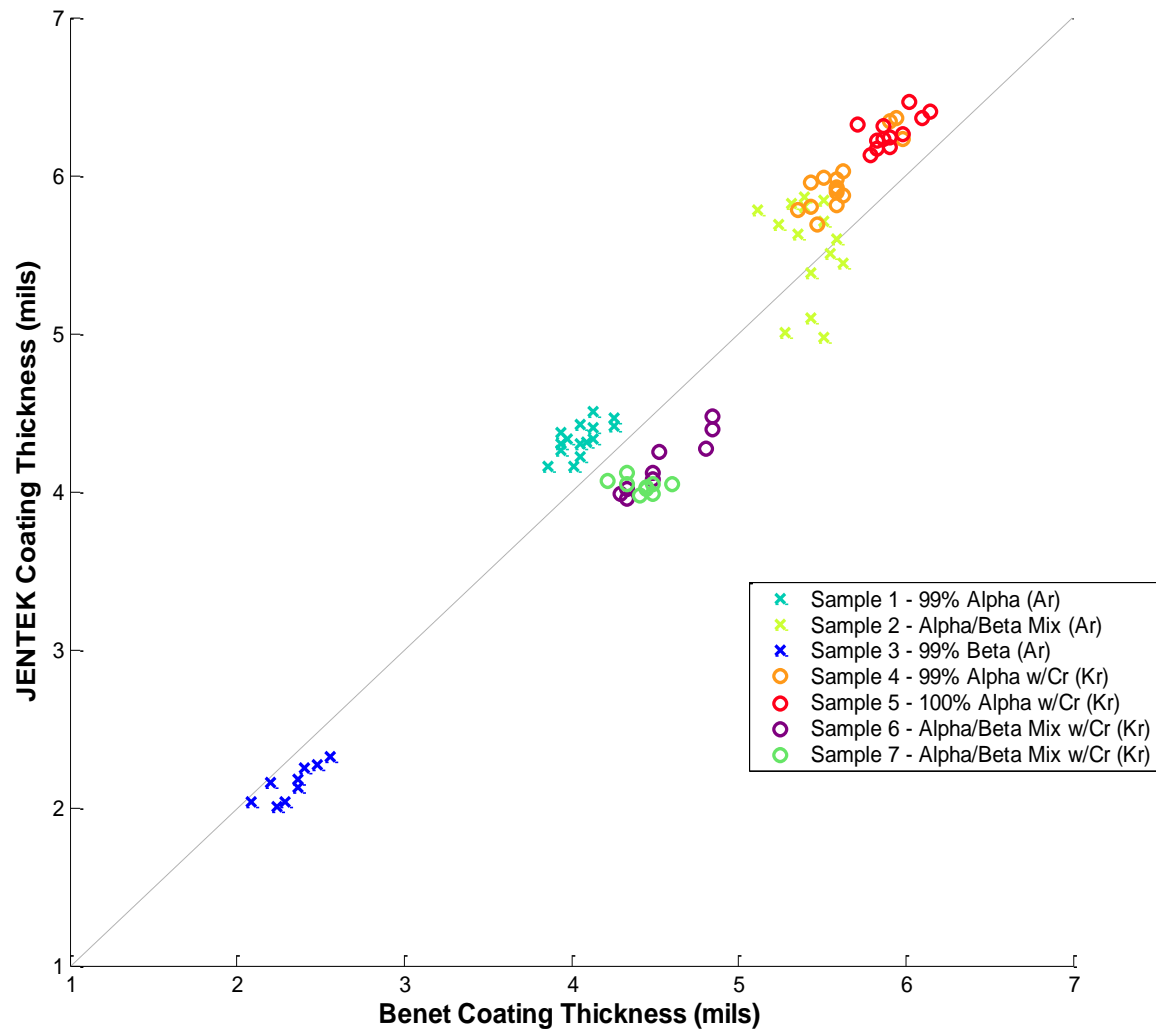


Steel Substrate Permeability (*rel*)

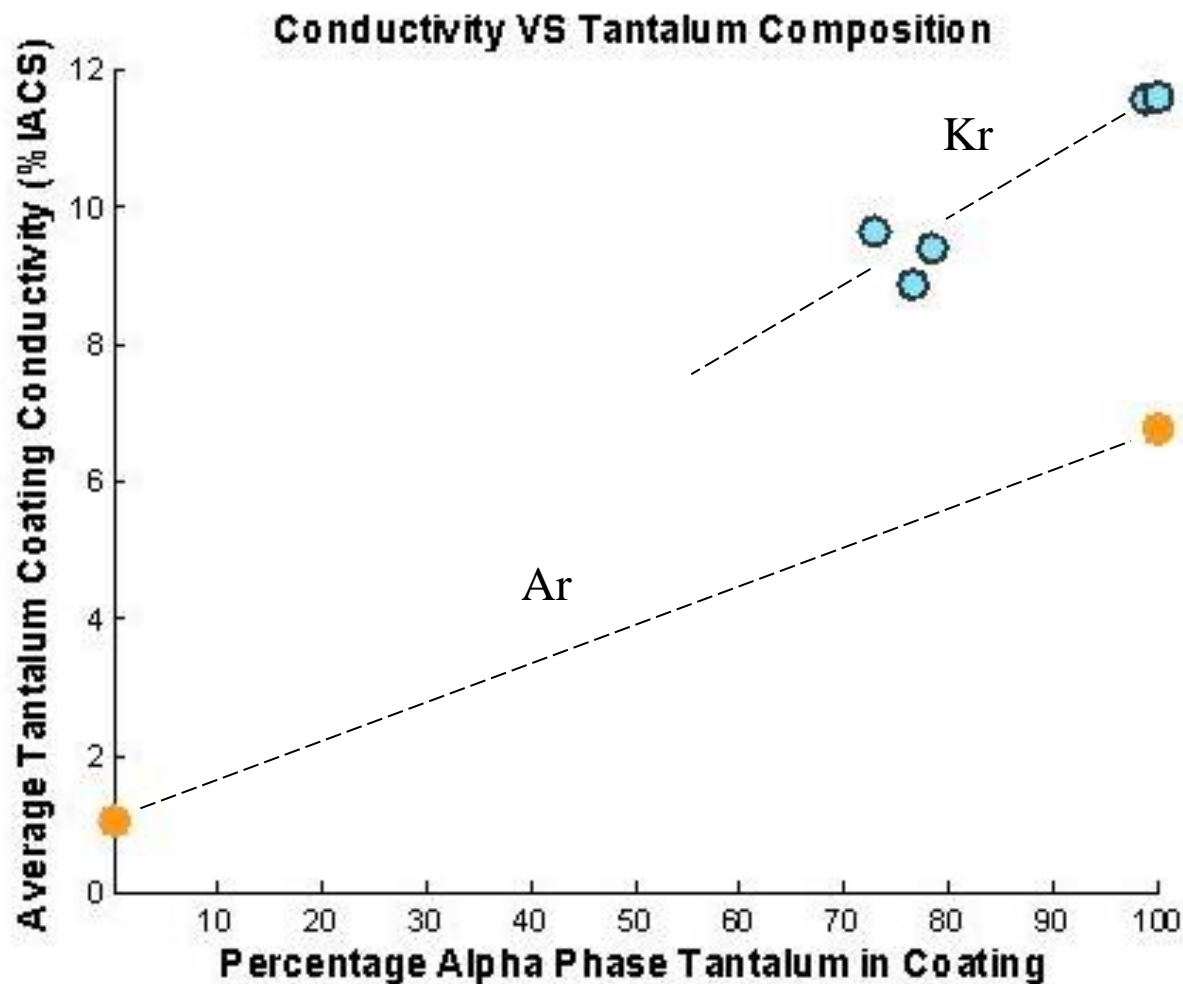


Lift-Off (*mils*)

# MWM-Array Measured Tantalum Coating Thickness Values



# Conductivity vs. Phase Composition for Tantalum Coatings





# Conclusions

- MWM sensors and MWM-Arrays can measure the **thickness** of tantalum coatings sputtered on gun barrel steel
- MWM sensors and MWM-Arrays can measure the **electrical conductivity** of tantalum coatings on gun barrel steel with & without chromium interlayers
  - ✓ Relative conductivities of pure  $\alpha$ -phase and mixed ( $\alpha+\beta$ ) phase regions depend on the **sputtering gas**. Pure  $\alpha$ -phase conductivity values are significantly different for coatings processed in argon vs. those sputtered in krypton, e.g., 6.74% IACS in the case of argon and about 11.5% IACS in the case of krypton
  - ✓ Assuming a priori knowledge of the process gas, MWM sensors & MWM-Arrays can **detect** and **determine** the extent of lower conductivity regions containing  **$\beta$ -phase**
- System is currently in pilot testing on 40” and 12” gun barrel sections. Also, successfully tested on full length 5 m large caliber gun barrel.